

April 1988 Revised January 2004

# 74F162A

# Synchronous Presettable BCD Decade Counter

## **General Description**

The 74F162A is a high-speed synchronous decade counter operating in the BCD (8421) sequence. They are synchronously presettable for applications in programmable dividers. The F162A has a Synchronous Reset input that overrides counting and parallel loading and allows all outputs to be simultaneously reset on the rising edge of the clock. The F162A is a high speed version of the F162.

#### **Features**

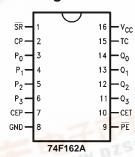
- Synchronous counting and loading
- High-speed synchronous expansion
- Typical count rate of 120 MHz

# **Ordering Code:**

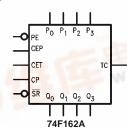
Order Number	Package Number	Package Description						
74F162ASC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow						
74F162APC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide						

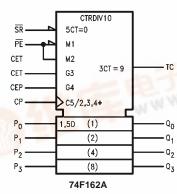
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

# **Connection Diagram**



## **Logic Symbols**







## **Unit Loading/Fan Out**

Dia Nama	December 1	U.L.	Input I <sub>IH</sub> /I <sub>IL</sub>	
Pin Names	Description	HIGH/LOW	Output I <sub>OH</sub> /I <sub>OL</sub>	
CEP	Count Enable Parallel Input	1.0/1.0	20 μA/-0.6 mA	
CET	Count Enable Trickle Input	1.0/2.0	20 μA/–1.2 mA	
СР	Clock Pulse Input (Active Rising Edge)	1.0/1.0	20 μA/-0.6 mA	
SR	Synchronous Reset Input (Active LOW)	1.0/2.0	20 μA/–1.2 mA	
P <sub>0</sub> -P <sub>3</sub>	Parallel Data Inputs	1.0/1.0	20 μA/-0.6 mA	
PE	Parallel Enable Input (Active LOW)	1.0/2.0	20 μA/–1.2 mA	
Q <sub>0</sub> –Q <sub>3</sub>	Flip-Flop Outputs	50/33.3	–1 mA/20 mA	
TC	Terminal Count Output	50/33.3	–1 mA/20 mA	

## **Functional Description**

The 74F162A count modulo-10 in the BCD (8421) sequence. From state 9 (HLLH) they increment to state 0 (LLLL). The clock inputs of all flip-flops are driven in parallel through a clock buffer. Thus all changes of the Q outputs occur as a result of, and synchronous with, the LOW-to-HIGH transition of the CP input signal. The circuits have four fundamental modes of operation, in order of precedence: synchronous reset, parallel load, count-up and hold. Four control inputs— Synchronous Reset (SR), Parallel Enable (PE), Count Enable Parallel (CEP) and Count Enable Trickle (CET)—determine the mode of operation, as shown in the Mode Select Table. A LOW signal on SR overrides counting and parallel loading and allows all outputs to go LOW on the next rising edge of CP. A LOW signal on PE overrides counting and allows information on the Parallel Data (Pn) inputs to be loaded into the flip-flops on the next rising edge of CP. With PE and SR HIGH, CEP and CET permit counting when both are HIGH. Conversely, a LOW signal on either CEP or CET inhibits counting.

The F162A uses D-type edge-triggered flip-flops and changing the  $\overline{SR}$ ,  $\overline{PE}$ , CEP and CET inputs when the CP is

in either state does not cause errors, provided that the recommended setup and hold times, with respect to the rising edge of CP, are observed.

The Terminal Count (TC) output is HIGH when CET is HIGH and counter is in state 9. To implement synchronous multistage counters, the TC outputs can be used with the CEP and CET inputs in two different ways. Please refer to the F568 datasheet. The TC output is subject to decoding spikes due to internal race conditions and is therefore not recommended for use as a clock or asynchronous reset for flip-flops, counters or registers. In the F162A decade counters, the TC output is fully decoded and can only be HIGH in state 9. If a decade counter is preset to an illegal state, or assumes an illegal state when power is applied, it will return to the normal sequence within two counts, as shown in the State Diagram.

Logic Equations:

$$\begin{aligned} \text{Count Enable} &= \text{CEP} \times \text{CET} \times \overline{\text{PE}} \\ &\text{TC} &= \text{Q}_0 \times \overline{\text{Q}}_1 \times \overline{\text{Q}}_2 \times \text{Q}_3 \times \text{CET} \end{aligned}$$

#### **Mode Select Table**

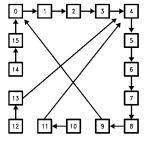
SR	PE	CET	CEP	Action on the Rising Clock Edge ()
L	Χ	Χ	Χ	Reset (Clear)
Н	L	Χ	X	
Н	Н	Н	Н	Count (Increment)
Н	Н	L	X	No Change (Hold)
Н	Н	X	L	No Change (Hold)

H = HIGH Voltage Level

L = LOW Voltage Level

X = Immaterial

# **State Diagram**



# **Logic Diagram** Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

# **Absolute Maximum Ratings**(Note 1)

 $_{-65^{\circ}C\ to\ +150^{\circ}C}$  Conditions

 $\begin{array}{ll} \mbox{Storage Temperature} & -65\mbox{°C to } +150\mbox{°C} \\ \mbox{Ambient Temperature under Bias} & -55\mbox{°C to } +125\mbox{°C} \\ \end{array}$ 

Input Voltage (Note 2) -0.5V to +7.0V Input Current (Note 2) -30 mA to +5.0 mA

Voltage Applied to Output

in HIGH State (with  $V_{CC} = 0V$ )

 $\begin{array}{ll} \text{Standard Output} & -0.5 \text{V to V}_{\text{CC}} \\ \text{3-STATE Output} & -0.5 \text{V to +5.5 V} \end{array}$ 

Current Applied to Output

in LOW State (Max) twice the rated  $I_{OL}$  (mA) ESD Last Passing Voltage (Min) 4000V

Free Air Ambient Temperature  $0^{\circ}$ C to  $+70^{\circ}$ C Supply Voltage +4.5V to +5.5V

**Recommended Operating** 

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

## **DC Electrical Characteristics**

Symbol	Parameter	Min	Тур	Max	Units	v <sub>cc</sub>	Conditions
V <sub>IH</sub>	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal
V <sub>IL</sub>	Input LOW Voltage			8.0	V		Recognized as a LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage			-1.2	V	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH 10% V <sub>CC</sub>	2.5			V	Min	I <sub>OH</sub> = -1 mA
	Voltage 5% V <sub>CC</sub>	2.7			V	IVIIII	$I_{OH} = -1 \text{ mA}$
V <sub>OL</sub>	Output LOW 10% V <sub>CC</sub>			0.5	V	Min	I <sub>OL</sub> = 20 mA
	Voltage			0.5	V	IVIIII	I <sub>OL</sub> = 20 IIIA
I <sub>IH</sub>	Input HIGH			5.0	μА	Max	V <sub>IN</sub> = 2.7V
	Current			5.0	μА	IVIAX	VIN - 2.7 V
I <sub>BVI</sub>	Input HIGH Current			7.0	μА	Max	V <sub>IN</sub> = 7.0V
	Breakdown Test						VIN = 7.0V
I <sub>CEX</sub>	Output HIGH			50	μА	Max	V <sub>OUT</sub> = V <sub>CC</sub>
	Leakage Current			30	μΛ	IVIAX	v001 - vCC
$V_{ID}$	Input Leakage	4.75			V	0.0	I <sub>ID</sub> = 1.9 μA
	Test	4.75			v	0.0	All Other Pins Grounded
I <sub>OD</sub>	Output Leakage			3.75	μА	0.0	V <sub>IOD</sub> = 150 mV
	Circuit Current			0.70	μιτ	0.0	All Other Pins Grounded
I <sub>IL</sub>	Input LOW			-0.6	mA	Max	$V_{IN} = 0.5V$ (CP, CEP,P <sub>n</sub> , $\overline{MR}$ (F160A))
	Current			-1.2	mA	Max	$V_{IN} = 0.5V (CET, \overline{SR} (F162A), \overline{PE})$
Ios	Output Short-Circuit Current	-60		-150	mA	Max	V <sub>OUT</sub> = 0V
I <sub>CC</sub>	Power Supply Current		37	55	mA	Max	V <sub>O</sub> = HIGH

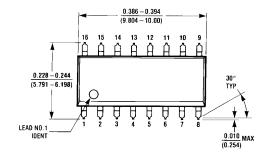
# **AC Electrical Characteristics**

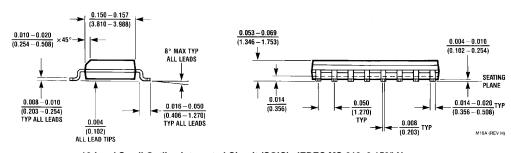
Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_A = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0$ V $C_L = 50$ pF		Units	
		Min	Тур	Max	Min	Max	Min	Max		
f <sub>MAX</sub>	Maximum Count Frequency	90	120		75		80		MHz	
t <sub>PLH</sub>	Propagation Delay, Count	3.5	5.5	7.5	3.5	9.0	3.5	8.5	ns	
t <sub>PHL</sub>	CP to Q <sub>n</sub> (PE Input HIGH)	3.5	7.5	10.0	3.5	11.5	3.5	11.0	115	
t <sub>PLH</sub>	Propagation Delay, Load	4.0	6.0	8.5	4.0	10.0	4.0	9.5	ns	
t <sub>PHL</sub>	CP to Q <sub>n</sub> (PE Input LOW)	4.0	6.0	8.5	4.0	10.0	4.0	9.5	115	
t <sub>PLH</sub>	Propagation Delay	5.0	10.0	14.0	5.0	16.5	5.0	15.0	no	
t <sub>PHL</sub>	CP to TC	5.0	10.0	14.0	5.0	15.5	5.0	15.0	ns	
t <sub>PLH</sub>	Propagation Delay	2.5	4.5	7.5	2.5	9.0	2.5	8.5	ns	
t <sub>PHL</sub>	CET to TC	2.5	4.5	7.5	2.5	9.0	2.5	8.5	115	

# **AC Operating Requirements**

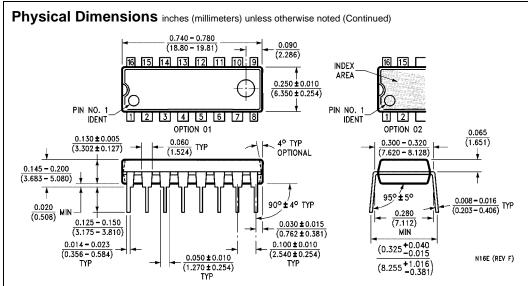
		T <sub>A</sub> = +25°C		$T_A = -55^{\circ}C \text{ to } +125^{\circ}C$		$T_A = 0$ °C to +70°C		
Symbol	Parameter	V <sub>CC</sub> =	$V_{CC} = +5.0V$		$V_{CC} = +5.0V$		$V_{CC} = +5.0V$	
		Min	Max	Min	Max	Min	Max	1
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	5.0				5.0		
t <sub>S</sub> (L)	P <sub>n</sub> to CP	5.0				5.0		ns
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	2.0		2.5		2.0		115
t <sub>H</sub> (L)	P <sub>n</sub> to CP	2.0		2.5		2.0		
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	11.0		13.5		11.5		
t <sub>S</sub> (L)	PE or SR to CP	8.5		10.5		9.5		ns
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	2.0		2.0		2.0		115
t <sub>H</sub> (L)	PE or SR to CP	0		0		0		
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	11.0		13.0		11.5		
t <sub>S</sub> (L)	CEP or CET to CP	5.0		6.0		5.0		no
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	0		0		0		ns
t <sub>H</sub> (L)	CEP or CET to CP	0		0		0		
t <sub>W</sub> (H)	Clock Pulse Width (Load)	5.0		5.0		5.0		no
$t_W(L)$	HIGH or LOW	5.0		5.0		5.0		ns
t <sub>W</sub> (H)	Clock Pulse Width (Count)	4.0		5.0		4.0		no
t <sub>W</sub> (L)	HIGH or LOW	6.0		8.0		7.0		ns

# Physical Dimensions inches (millimeters) unless otherwise noted





16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M16A



16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N16E

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